

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination KRAENZEL ET AL.	
		Examiner Dean T. Nguyen	Art Unit 3689	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0141560	10-2002	Khayatan et al.	379/219
*	B	US-2002/0149738	10-2002	McCormick, William	351/112
*	C	US-2002/0032603	03-2002	Yeiser, John O.	705/14
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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